



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(on)} max	I _D Max T _A = +25°C (Notes 5 & 7)
Q1	30V	32mΩ @ V _{GS} = 10V	8.1A
Qi		46mΩ @ V _{GS} = 4.5V	6.1A
02	201/	39mΩ @ V _{GS} = -10V	-7A
Q2	Q2 -30V	53mΩ @ V _{GS} = -4.5V	-5.6A

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Power Management Functions
- Analog Switch
- Load Switch

Features

- Low On-Resistance
- N-Channel: 32mΩ @ 10V

46mΩ @ 4.5V

P-Channel: 39mΩ @ 10V

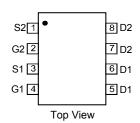
53mΩ @ 4.5V

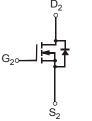
- Low Input Capacitance
- · Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

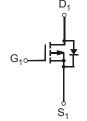
Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper lead frame.
 Solderable per MIL-STD-202, Method 208 <a>®
- Marking Information (See Page 2)
- Ordering Information
- Weight: 0.072 grams (approximate)









N-Channel MOSFET

P-Channel MOSFET

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3032LSD-13	SO-8	2,500/Tape & Reel

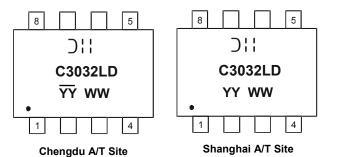
SO-8

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.



Marking Information



⊃¦¦ = Manufacturer's Marking
 C3032LD = Product Type Marking Code
 YYWW = Date Code Marking
 YY or YY = Year (ex: 14 = 2014)
 WW = Week (01 - 53)

YY = Date Code Marking for SAT (Shanghai Assembly/ Test site)
YY = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Maximum Ratings N-CHANNEL - Q1 @TA = +25°C unless otherwise specified

Cha	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	30	V
Gate-Source Voltage	V _{GSS}	±20	V
Continuous Drain Current (Note 5)	I _D	8.1 5.1	Α
Pulsed Drain Current (Note 6)	I _{DM}	25	Α

Maximum Ratings P-CHANNEL – Q2 @TA = +25°C unless otherwise specified

Chai	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-30	V
Gate-Source Voltage	V _{GSS}	±20	V
Continuous Drain Current (Note 5)	I _D	-7.0 -4.5	Α
Pulsed Drain Current (Note 6)	I _{DM}	-25	Α

Thermal Characteristics @TA = +25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)		2.5	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	50	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

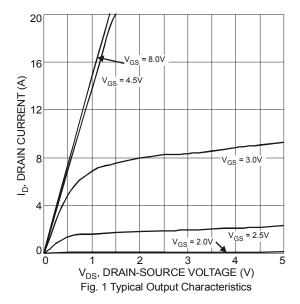
Notes:

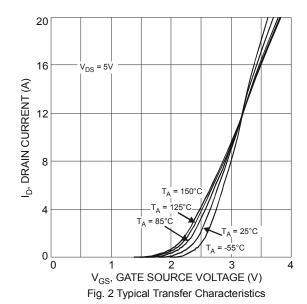
- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout.
- 6. Repetitive rating, pulse width limited by junction temperature.



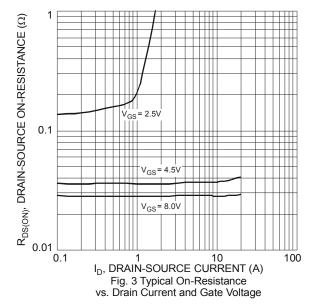
Electrical Characteristics N-CHANNEL - Q1 @TA = +25°C unless otherwise specified

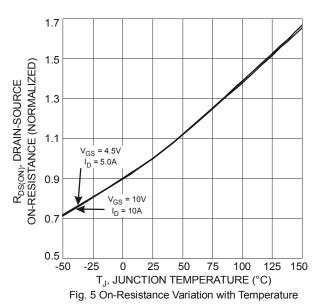
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T _J = 25°C	I _{DSS}	-	-	1	μA	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)				ā.		
Gate Threshold Voltage	$V_{GS(th)}$	1	1.45	2.1	V	$V_{DS} = V_{GS}, I_{C} = 250 \mu A$
Static Drain-Source On-Resistance			23	32	mΩ	$V_{GS} = 10V, I_C = 7A$
Static Dialii-Source Off-Resistance	R _{DS (ON)}	-	32	46		$V_{GS} = 4.5V, I_C = 5.6A$
Forward Transfer Admittance	Y _{fs}	-	7.6	-	S	$V_{DS} = 5V, I_{C} = 7A$
Diode Forward Voltage (Note 7)	V_{SD}	-	0.7	1	V	$V_{GS} = 0V$, $I_S = 1A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	-	404.5	-	pF	\ - 45\\ \\ - 0\\
Output Capacitance	Coss	-	51.8	-	pF	$V_{DS} = 15V, V_{GS} = 0V,$ -f = 1MHz
Reverse Transfer Capacitance	C _{rss}	-	45.1	-	pF	1 - 11/11/12
Gate Resistance	R_g	-	1.5	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (10V)	Q_{g}	-	9.2	-	nC	V - 40V V - 45V
Gate-Source Charge	Qgs	-	1.2	-	nC	$V_{GS} = 10V, V_{DS} = 15V,$ $V_{ID} = 5.8A$
Gate-Drain Charge	Q_{gd}	-	1.8	-	nC	ID - 3.6A
Turn-On Delay Time	t _{D(on)}	-	3.4	-	ns	
Turn-On Rise Time	t _r	-	6.18	-	ns	V _{GS} = 10V, V _{DS} = 15V,
Turn-Off Delay Time	t _{D(off)}	-	13.92	-	ns	$R_G = 3\Omega$, $R_L = 2.6\Omega$
Turn-Off Fall Time	t _f	-	2.84	-	ns	

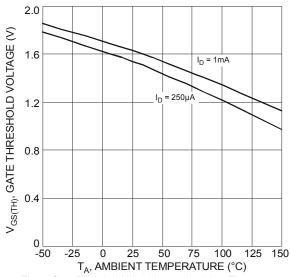


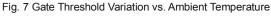












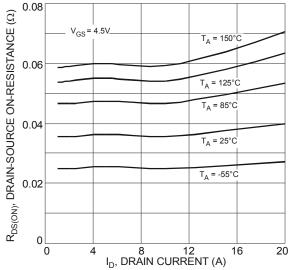


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

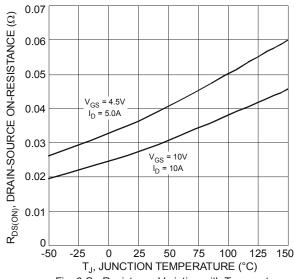


Fig. 6 On-Resistance Variation with Temperature

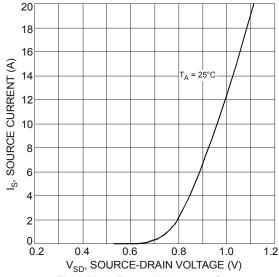
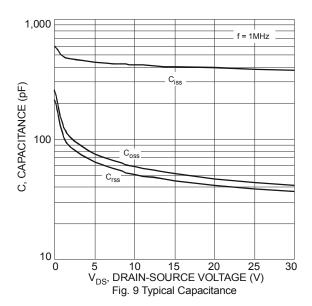


Fig. 8 Diode Forward Voltage vs. Current





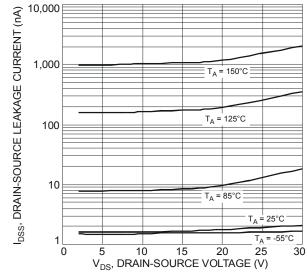


Fig. 10 Typical Drain-Source Leakage Current vs. Drain-Source Voltage

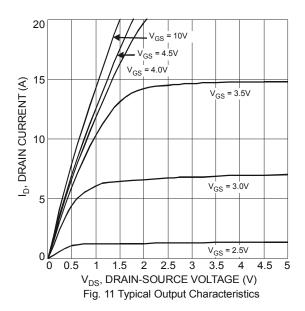


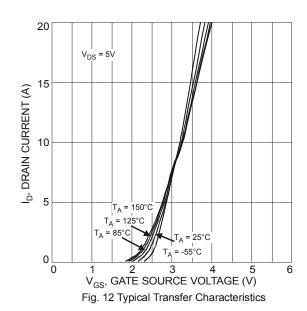
Electrical Characteristics P-CHANNEL @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						•
Drain-Source Breakdown Voltage	BV_{DSS}	-30	-	-	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current T _J = 25°C	I _{DSS}	1	-	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	-1	-1.7	-2.2	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance	J		30	39	mΩ	$V_{GS} = -10V, I_D = -4.3A$
Static Drain-Source On-Resistance	R _{DS (ON)}	-	42	53	11122	$V_{GS} = -4.5V, I_D = -3.7A$
Forward Transfer Admittance	Y _{fs}	-	7	-	S	$V_{DS} = -5V, I_{D} = -4.3A$
Diode Forward Voltage (Note 7)	V_{SD}	-	-0.75	-1	V	$V_{GS} = 0V, I_{S} = -1.7A$
DYNAMIC CHARACTERISTICS (Note 8)						_
Input Capacitance	C _{iss}	ı	1002	-	pF	151/11/
Output Capacitance	Coss	-	125	-	pF	$V_{DS} = -15V, V_{GS} = 0V,$ - f = 1MHz
Reverse Transfer Capacitance	C _{rss}	-	118	-	pF	- IIVIH2
Gate Resistance	Rg	-	13	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (4.5V)	Qg	-	10.1	-	nC	
Total Gate Charge (10V)	Q_{g}	-	21.1	-	nC	$V_{GS} = -4.5V/-10V, V_{DS} = -15V,$
Gate-Source Charge	Q_{gs}	-	2.8	-	nC	I _D = -6A
Gate-Drain Charge	Q _{gd}	-	3.2	-	nC	
Turn-On Delay Time	t _{D(on)}	-	10.1	-	ns	
Turn-On Rise Time	tr	-	6.5	-	ns	V _{GS} = -10V, V _{DS} = -15V,
Turn-Off Delay Time	t _{D(off)}	-	50.1	-	ns	$R_G = 6\Omega$, $I_D = -1A$
Turn-Off Fall Time	t _f	-	22.2	-	ns	

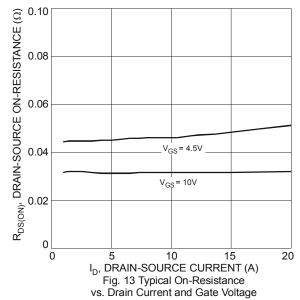
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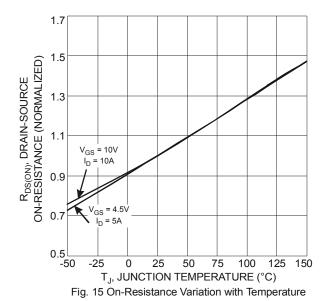
- 7. Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to production testing.











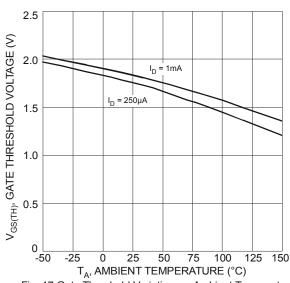


Fig. 17 Gate Threshold Variation vs. Ambient Temperature

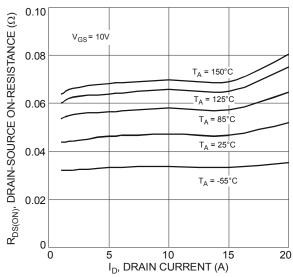


Fig. 14 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

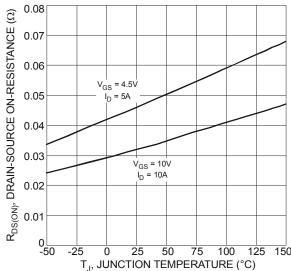


Fig. 16 On-Resistance Variation with Temperature

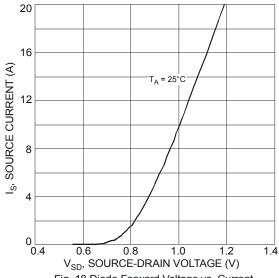
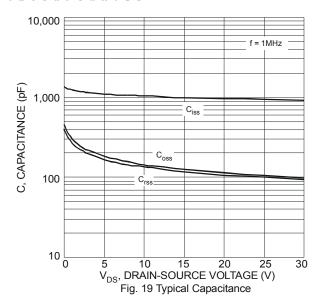


Fig. 18 Diode Forward Voltage vs. Current





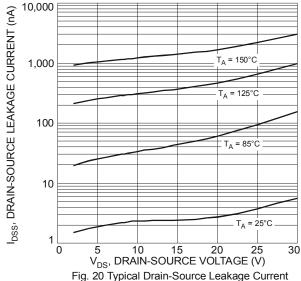
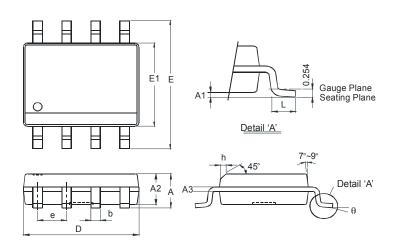


Fig. 20 Typical Drain-Source Leakage Current vs. Drain-Source Voltage

Package Outline Dimensions

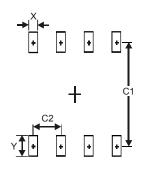
Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



SO-8					
Dim	Min	Max			
Α	-	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27	Тур			
h	- 0.35				
٦	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
X	0.60
Y	1.55
C1	5.4
C2	1 27



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